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Ref #	Hits	Search Query	DBs	Default Operator	Plurals	Time Stamp
L1	38	mask preference filter\$3	US-PGPUB; USPAT; EPO; JPO; IBM_TDB	SAME	ON	2005/02/21 09:18
L2	1	updat\$3 preference filter\$3 directory	US-PGPUB; USPAT; EPO; JPO; IBM_TDB	SAME	ON	2005/02/21 09:15
L3	40	(directory same tree) same updat\$3 same database	USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/02/21 09:17
L4	_ 227	mask value updat\$3 change	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	SAME	ON	2005/02/21 09:19
L5	0	L4 checksum	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	SAME	ON	2005/02/21 09:16
L6	958	715/513.ccls.	USPAT; EPO; JPO; IBM_TDB	OR	ON	2005/02/21 09:16
L7	239	715/514.ccls.	USPAT; EPO; JPO; IBM_TDB	OR	ON	2005/02/21 09:16
L8	194	715/511.ccls.	USPAT; EPO; JPO; IBM_TDB	OR	ON	2005/02/21 09:16
L9	963	707/203.ccls.	USPAT; EPO; JPO; IBM_TDB	OR	ON	2005/02/21 09:16
L10	7	filter\$3 mask value track\$3 change	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	SAME	ON	2005/02/21 09:17
L11	0	4 (web adj page)	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	SAME	ON	2005/02/21 09:19

	1	Document ID	Issue Date	Title	Current OR	Inventor	PT
1		US 6819673 B1	20041116	Method and system for establishing SNA sessions over wide area networks	370/400	Giroir; Didier et al.	
2		US 6816479 B1	20041109	Method and system for pre-loading in an NBBS network the local directory database of network nodes with the location of the more frequently requested resources	370/351	Euget; Guy et al.	
3		US 6775782 B1	20040810	System and method for suspending and resuming digital certificates in a certificate-based user authentication system	713/201	Buros; Karen Lynn et al.	
4		US 6772139 B1	20040803	Method and apparatus for facilitating use of hypertext links on the world wide web	707/3	Smith, III; Julius O.	

	1	Document ID	Issue Date	Title	Current OR	Inventor	PT
1		US 20050025 377 A1	20050203	Method and apparatus for signal-to-noise ratio dependent image processing	382/260	Avinash, Gopal B. et al.	
2		US 20050007 249 A1	20050113	Integrated alert generation in a process plant	340/511	Eryurek, Evren et al.	
26		US 6753965 B2	•	Defect detection system for quality assurance using automated visual inspection	356/431	Kumar; Ajay et al.	